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Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

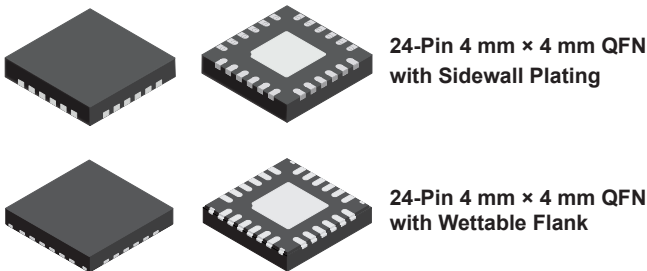


Multiple-Output Regulator for Automotive LCD Displays

FEATURES AND BENEFITS

- Automotive-grade AEC-Q100 qualified
- Input voltage from 3 to 10 V
- Four individual output supplies
- Independent control of each output voltage
- Boost switching frequency: 350 kHz to 2.25 MHz
- External synchronization capability is available
- Frequency dithering to reduce EMI
- Less than 10 μ A shutdown current
- Protection features: overcurrent, overvoltage, short circuit, and thermal overload protection
- Fully programmable outputs through I²C
 - Regulator voltage
 - Startup/shutdown sequences
 - Fault retry counter

PACKAGES:



Not to scale

DESCRIPTION

The A8603 is a fixed-frequency, multiple-output supply for LCD bias. Its switching frequency can be either programmed or synchronized with an external clock signal between 350 kHz and 2.25 MHz. This will minimize interference with AM and FM radio bands.

An I²C-compliant serial interface allows a system microcontroller to configure the A8603 by writing into its internal registers. A system controller can also access the A8603 status registers in case of fault conditions.

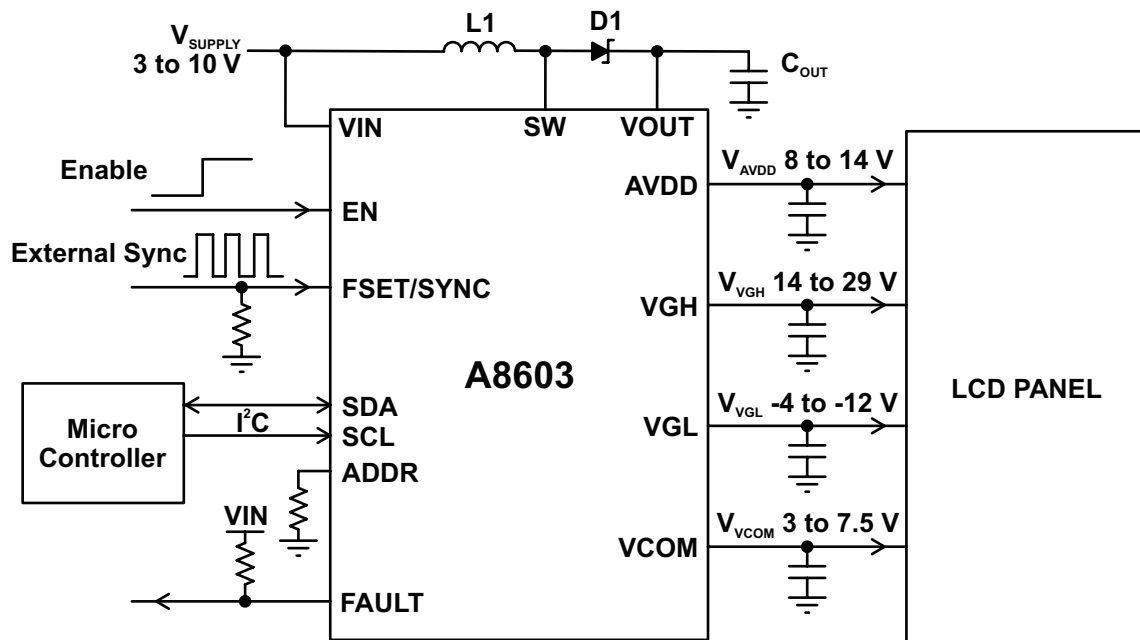
The A8603 incorporates a boost stage followed by two linear regulators and two charge-pump regulators. Each output voltage can be programmed independently through serial interface. During power-up and shutdown, the outputs are turned on and off in preprogrammed sequences with adjustable delay. This will meet the sequencing requirements for specific LCD panels.

Short-circuit protection is provided for all outputs. The boost switch is protected against overcurrent and overvoltage.

The A8603 is provided in a 24-pin 4 mm × 4 mm QFN package, with exposed thermal pad to allow operation at high ambient temperatures. It is lead (Pb) free with 100% matte-tin leadframe plating.

APPLICATIONS

- GPS
- Infotainment
- Medium LCDs



System Block Diagram Showing Typical Regulator Voltages

Table 1: Selection Guide

Part Number	Package	Packing*	Pin Soldering
A8603KESTR-R	24-pin 4x4 QFN with exposed thermal pad	1500 pieces per 13-in. reel	Sidewall Plating
A8603KESTR-J	24-pin 4x4 QFN with exposed thermal pad	Contact Factory	Wettable Flank

*Contact Allegro™ for additional packing options.



Table of Contents

Specifications	3	VGL/VGH Charge Pumps	18
Absolute Maximum Ratings	3	Boost Controller	20
Thermal Characteristics	3	Boost Switching Frequency	22
Pinout Diagrams and Terminal List Table	4	Boost Frequency Dithering	23
Functional Block Diagram	5	Fault Conditions	24
Electrical Characteristics	6	Over- and Undervoltage Protections	24
Characteristic Performance	10	Overcurrent Protection	24
Functional Description	12	Examples of Various Fault Conditions	25
Program Diagnostics	12	Pre-Output Fault Detection	29
Programmable Registers	13	General Fault Detection	29
I ² C Register Map	14	Fault Monitoring	31
Diagnostic Registers	15	Fault1 (Group1)	31
Real-Time Status Registers	15	Fault2 (Group2)	31
Latched Status Registers	16	Fault3 (Group3)	31
Description of Regulators	17	Thermal Analysis	33
AVDD Regulator	17	Boost Stage Power Loss	33
VCOM Regulator	17	Output Regulator Power Loss	33
		Package Outline Drawing	35

SPECIFICATIONS

ABSOLUTE MAXIMUM RATINGS^{[1][2][5]}

Characteristic	Symbol	Notes	Rating	Unit
VIN Pin Voltage	V _{IN}	All voltages measured with respect to GND	-0.3 to 11	V
SW Pin Voltage ^{[3][4]}	V _{SW}	Continuous	-0.6 to 22	V
		Voltage spikes (pulse width < 100 ns)	-1 to 40	V
OUT Pin Voltage	V _{OUT}		-0.3 to 22	V
AVDD Pin Voltage	V _{AVDD}		-0.3 to lower of 16 or V _{OUT} + 0.3	V
CP11 Pin Voltage	V _{CP11}	Positive charge pump	-0.3 to 31	V
CP12 Pin Voltage	V _{CP12}	Positive charge pump	-0.3 to V _{CP11} + 0.3	V
VGH and VGH3 Pin Voltage	V _{VGH} , V _{VGH3}	Positive charge pump	-0.3 to 31	V
CP21 Pin Voltage	V _{CP21}	Negative charge pump	-0.3 to 14	V
CP22 and VGL Pin Voltage	V _{CP22} , V _{VGL}	Negative charge pump	-14 to 0.3	V
FAULT Pin Voltage	V _{FAULT}		-0.3 to lower of 10 or V _{VIN} + 0.3	V
BIAS, COMP, FSET Pin Voltage	V _{BIAS} , V _{COMP} , V _{FSET}		-0.3 to 3.3	V
VCOM Pin Voltage	V _{VCOM}		-0.3 to lower of 8.5 or V _{AVDD} + 0.3	V
AGND, PGND and GNDVCOM Pin Voltage	V _{AGND} , V _{PGND} , V _{GNDVCOM}		-0.3 to 0.3	V
Logic Pins (EN, SCL, SDA, ADDR, NC)	-		-0.3 to 5.5	V
Operating Ambient Temperature	T _A	K temperature range	-40 to 125	°C
Maximum Junction Temperature	T _{J(max)}		150	°C
Storage Temperature	T _{stg}		-55 to 150	°C

¹ Stresses beyond those listed in this table may cause permanent damage to the device. The Absolute Maximum ratings are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics table is not implied. Exposure to Absolute Maximum-rated conditions for extended periods may affect device reliability.

² All voltages referenced to AGND.

³ The SW pin has internal clamp diodes to GND. Applications that forward bias this diode should take care not to exceed the IC package power dissipation limits. Note: Exact energy specification to be determined.

⁴ The switch DMOS is self-protected. If voltage spikes exceeding 40 V are applied, the device would conduct and absorb the energy safely.

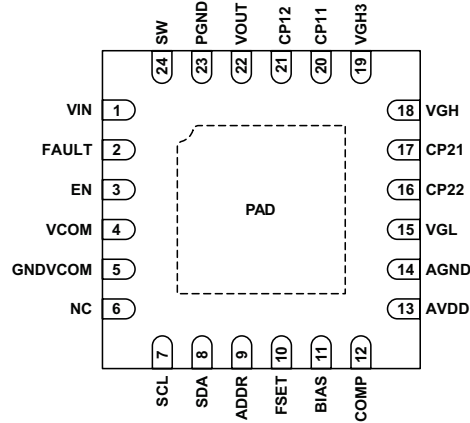
⁵ When V_{IN} = 0 (no power), all inputs are limited by -0.3 to 5.5 V.

THERMAL CHARACTERISTICS: May require derating at maximum conditions; see application information

Characteristic	Symbol	Test Conditions ^[6]	Value	Unit
Package Thermal Resistance	R _{θJA}	Package ES on 4-layer PCB based on JEDEC standard	37	°C/W

⁶ Additional thermal information available on the Allegro website.

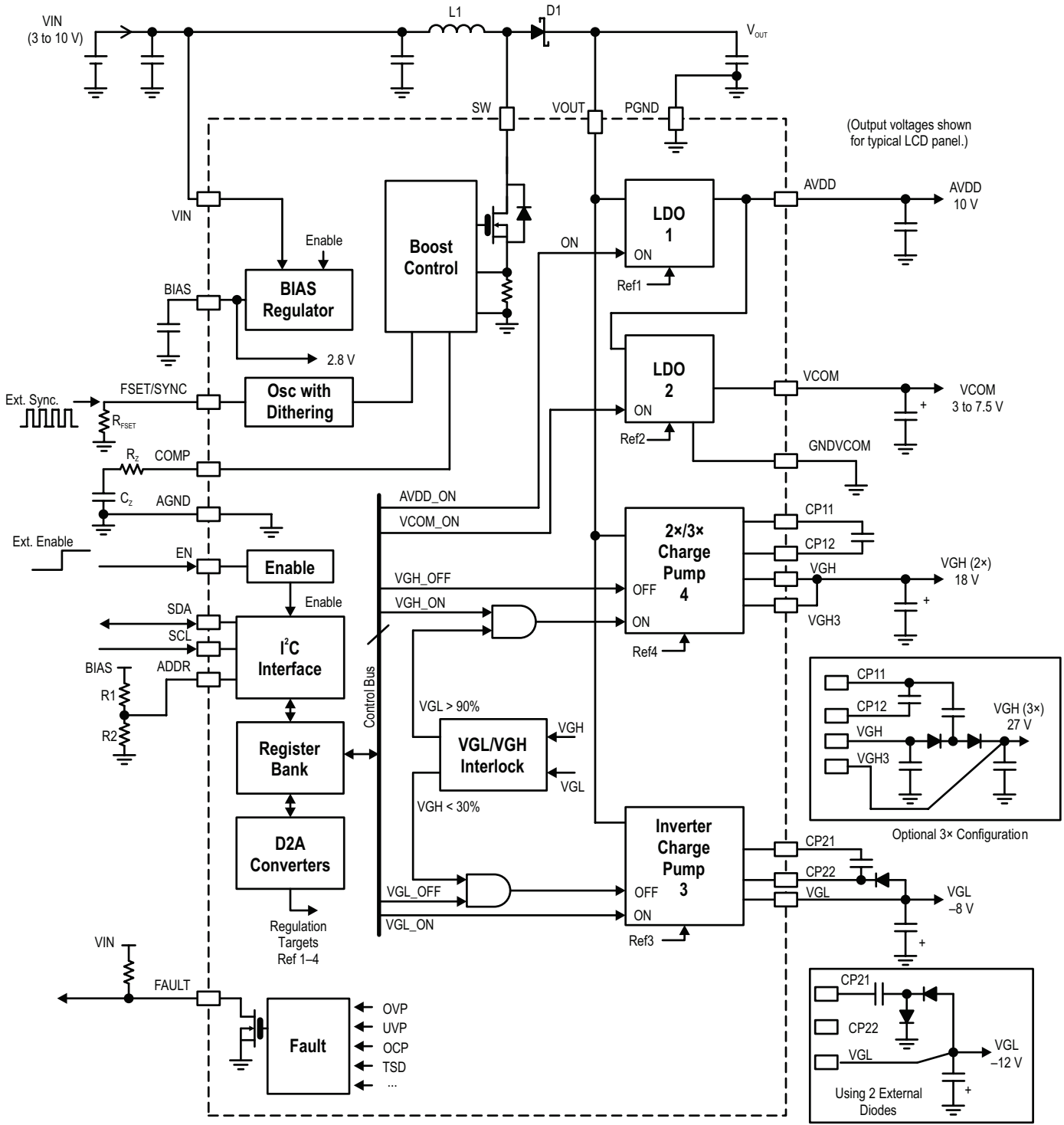
PINOUT DIAGRAMS AND TERMINAL LIST TABLE



Package ES, 24-Pin QFN Pinouts

Terminal List Table

Number	Name	Function
1	VIN	Input supply voltage (3 to 10 V) for the IC
2	FAULT	Open-drain output, pulls low in case of error condition
3	EN	Enable pin for enabling the IC; system can only be enabled after V_{IN} is above UVLO level (refer to Startup Timing Diagram)
4	VCOM	Output from internal low-dropout (LDO) regulator (item 2 in Functional Block Diagram) powered by AVDD
5	GNDVCOM	Ground reference for VCOM; connect to ground plane
6	NC	No Connect (reserved for Test Mode); connect to GND in actual PCB
7	SCL	I ² C clock signal
8	SDA	I ² C data signal
9	ADDR	I ² C address selection (up to 4 physical IC addresses based on voltage level)
10	FSET	Input for synchronizing boost and charge pump signals switching frequency to external clock signal; alternatively, it can be connected to an external resistor to set the switching frequency
11	BIAS	Output from internal 2.8 V bias regulator; connect to GND via 1 μ F ceramic capacitor for decoupling
12	COMP	Compensation pin, connect to external COMP components (R_Z and C_Z)
13	AVDD	Output from internal LDO (item 1 in Functional Block Diagram) powered by V_{OUT}
14	AGND	Analog GND reference for signals; connect to ground plane
15	VGL	Inverted charge pump output (item 3 in Functional Block Diagram)
16	CP22	Capacitor terminals for inverted charge pump (item 3 in Functional Block Diagram)
17	CP21	
18	VGH	2 \times charge pump output (item 4 in Functional Block Diagram)
19	VGH3	3 \times charge pump output (item 4 in Functional Block Diagram)
20	CP11	Capacitor terminals for charge pump (item 4 in Functional Block Diagram)
21	CP12	
22	VOUT	Connect to boost output for internal LDO and charge pump regulators
23	PGND	Power ground for internal boost switch; connect this pin to ground terminal of output ceramic capacitor(s)
24	SW	Internal boost converter switch node
–	PAD	



Functional Block Diagram

ELECTRICAL CHARACTERISTICS [1]: Valid at $V_{IN} = 5\text{ V}$, $EN = \text{high}$, $f_{SW} = 2\text{ MHz}$, $V_{AVDD} = 10\text{ V}$, $V_{VGH1} = 20\text{ V}$, $V_{VGL} = -8\text{ V}$, $T_J = T_A = 25^\circ\text{C}$, except • indicates specifications guaranteed for $T_J = T_A = -40^\circ\text{C}$ to 125°C , unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
INPUT VOLTAGE AND CURRENT						
Input Voltage	V_{IN}		• 3	–	10	V
VIN Pin Undervoltage Lockout (UVLO) Threshold	V_{UVLO}	V_{IN} rising	• –	2.8	2.9	V
VIN Pin UVLO Hysteresis	$V_{UVLO(HYS)}$		–	0.15	0.25	V
BIAS Voltage	V_{BIAS}	Internal BIAS regulator, $EN = \text{high}$	–	2.8	–	V
Shutdown BIAS Current [1]	$I_{VINBIAS(SD)}$	Current into VIN pin, $EN = \text{low}$	• –	1	10	μA
Standby BIAS Current	$I_{VINBIAS(STB)}$	$EN = \text{high}$, output disabled	–	3	–	mA
Operating BIAS Current	$I_{VINBIAS(OP)}$	$EN = \text{high}$, output enabled	–	6	–	mA
BOOST SWITCH						
Switch Peak Current Limit	I_{SWILIM}	Cycle-by-cycle current limit	• 2.2	2.6	3	A
Switch Secondary Current Limit	$I_{SWILIM2}$	Trips SW_OCP fault if exceeded	–	3.7	–	A
Switch On-Resistance	$R_{DS(on)}$	$I_{SW} = 0.4\text{ A}$	–	0.4	0.7	Ω
Switch Minimum On-Time	$t_{ON(MIN)}$		• –	65	120	ns
Switch Minimum Off-Time	$t_{OFF(MIN)}$		• –	60	100	ns
SW Pin Leakage Current	$I_{SW(LKG)}$	$V_{SW} = 5\text{ V}$, $EN = \text{low}$	–	0.1	–	μA
VOUT Pin Leakage Current	$I_{OUT(LKG)}$	$V_{OUT} = 5\text{ V}$, $EN = \text{low}$	–	0.1	–	μA
		$V_{OUT} = 10\text{ V}$, $EN = \text{low}$	–	25	37	μA
SW Pin Overvoltage Protection Threshold	$V_{SW(OVP)}$	Measured from SW to GND	• 18.6	21	23	V
SW OVP Detection Time [2]	$t_{SW(OVP)}$	Minimum pulse width required for $V_{SW} \geq V_{SW(OVP)}$ to be detected as SW OVP	–	40	–	ns
SW OVP to Shutdown Delay [2]	$t_{FAULT(OVP)}$	Delay from SW OVP to FAULT = L	–	1	2.5	μs
SWITCHING FREQUENCY/SYNCHRONIZATION						
FSET_SYNC Pin Voltage	$V_{FSETSYNC}$	Without using external synchronization signal	–	0.64	–	V
FSET_SYNC Pin Current	$I_{FSETSYNC}$		22	–	140	μA
Switching Frequency	f_{SW}	$R_{FSET_SYNC} = 5.1\text{ k}\Omega$	• 1.8	2	2.2	MHz
Synchronization Frequency	f_{SYNC}	External logic signal connected to FSET_SYNC pin	• 0.35	–	2.25	MHz
Synchronization Minimum On-Time	$t_{SYNC(ON)}$		• 150	–	–	ns
Synchronization Minimum Off-Time	$t_{SYNC(OFF)}$		• 150	–	–	ns
Switching Frequency Dithering Range	Δf_{SW0}	No external synch, REG0x10 = '00b'	–	0	–	%
		No external synch, REG0x10 = '01b'	–	5	–	%
		No external synch, REG0x10 = '10b'	–	10	–	%
		No external synch, REG0x10 = '11b'	–	15	–	%

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ELECTRICAL CHARACTERISTICS [1] (continued): Valid at $V_{IN} = 5\text{ V}$, EN = high, $f_{SW} = 2\text{ MHz}$, $V_{AVDD} = 10\text{ V}$, $V_{VGH1} = 20\text{ V}$, $V_{VGL} = -8\text{ V}$, $T_J = T_A = 25^\circ\text{C}$, except • indicates specifications guaranteed for $T_J = T_A = -40^\circ\text{C}$ to 125°C , unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
ERROR AMPLIFIER						
Open-Loop Voltage Gain [2]	A_{VOL}		–	43	–	dB
Transconductance [2]	g_m	$I_{COMP} = \text{between } -100\ \mu\text{A and } 100\ \mu\text{A}$	–	550	–	$\mu\text{A/V}$
EA Source Current	I_{EA_SRC}	$V_{COMP} = 0.7\text{ V}$, V_{OUT} below regulation target	–	200	–	μA
EA Sink Current	I_{EA_SINK}	$V_{COMP} = 0.7\text{ V}$, V_{OUT} over regulation target	–	200	–	μA
COMP Pull-Down Resistor	R_{COMP1}	Active pull-down when EN = H, Boost disabled	–	2.5	–	k Ω
	R_{COMP2}	Passive pull-down when EN = L	–	450	–	k Ω
LOGIC INPUTS						
EN Pin Logic High	V_{IH_EN}		• 1.8	–	–	V
EN Pin Logic Low	V_{IL_EN}		• –	–	0.8	V
Internal Pull-Down Resistance to AGND	$R_{EN(PD)}$		–	100	–	k Ω
Hard-Reset Duration [2]	t_{RESET}	EN = L duration in order to initiate a hardware reset during normal operation	2	–	–	μs
FSET Pin Input Logic High	V_{IH_FSE}	When used in external sync mode	• 1.5	–	–	V
FSET Pin Input Logic Low	V_{IL_FSE}	When used in external sync mode	• –	–	0.4	V
OVER- AND UNDERVOLTAGE PROTECTION FOR OUTPUT REGULATORS						
Output Overvoltage Fault Threshold	$V_{OUTX(OV)}$	Output rising; measured as % of target voltage	–	120	–	%
Output Undervoltage Fault Threshold	$V_{OUTX(UV)}$	Output falling; measured as % of target voltage	–	80	–	%
OUTPUT REGULATORS						
AVDD Output Voltage	V_{AVDD}		• 5	–	15	V
VCOM Output Voltage	V_{VCOM}	$V_{AVDD} > V_{VCOM} + 1.5\text{ V}$	• 2.5	–	7.5	V
VGH Output Voltage	V_{VGH}	VGH & VGH3 shorted	• 10	–	30	V
VGL Output Voltage	V_{VGL}		• -12	–	-4	V
Boost Minimum Headroom for AVDD Regulator	$V_{AVDD(DO)}$	Defined as $V_{OUT} - V_{AVDD}$; when AVDD = 15 V, $I_{OUT} = 100\text{ mA}$	–	2.1	–	V
Boost Minimum Headroom for VGH Regulator	$V_{VGH(DO)}$	Defined as $V_{OUT} - V_{VGH} / 2$; when $V_{VGH} = 24\text{ V}$, $I_{OUT} = 8\text{ mA}$	–	2.9	–	V
Boost Minimum Headroom for VGL Regulator	$V_{VGL(DO)}$	Defined as $V_{OUT} - (-V_{VGL})$; when $V_{VGL} = -12\text{ V}$, $I_{OUT} = -8\text{ mA}$	–	3.5	–	V
Output Pull-Down Resistor During Shutdown (AVDD, VCOM)	R_{OUTPD1}	EN = high, output disabled	–	250	–	Ω
Output Pull-Down Resistor During Shutdown (VGH, VGL)	R_{OUTPD2}	EN = high, output disabled	–	500	–	Ω
Output Pull-Down Resistor in Sleep Mode (AVDD, VCOM, VGH)	R_{OUTPD3}	EN = low, $V_{IN} > V_{UVLO}$	–	1	–	k Ω
Output Pull-Down Resistor in Sleep Mode (VGL only)	R_{OUTPD4}	EN = low	–	10	–	k Ω

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ELECTRICAL CHARACTERISTICS [1] (continued): Valid at $V_{IN} = 5\text{ V}$, $EN = \text{high}$, $f_{SW} = 2\text{ MHz}$, $V_{AVDD} = 10\text{ V}$, $V_{VGH1} = 20\text{ V}$, $V_{VGL} = -8\text{ V}$, $T_J = T_A = 25^\circ\text{C}$, except * indicates specifications guaranteed for $T_J = T_A = -40^\circ\text{C}$ to 125°C , unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
OUTPUT CURRENT CAPACITY							
AVDD OCP Trip Level	$I_{AVDD(OCP)}$	Includes I_{VCOM}	200	275	350	mA	
VCOM OCP Trip Level	$I_{VCOM(OCP)}$		36	45	54	mA	
VGH OCP Trip Level	$I_{VGH(OCP)}$		11	20	26	mA	
VGL OCP Trip Level	$I_{VGL(OCP)}$	Current into VGL pin	11	20	26	mA	
OUTPUT VOLTAGE ACCURACY							
AVDD, VGH, and VGL Load Regulation	$V_{AVDDreg}$ V_{VGHreg} V_{VGLreg}	$V_{AVDD} = 10\text{ V}$, $I_{AVDD} = 10\text{ to }100\text{ mA}$ $V_{VGH} = 20\text{ V}$, $I_{VGH} = 0.4\text{ to }4\text{ mA}$ $V_{VGL} = -8\text{ V}$, $I_{VGL} = -0.8\text{ to }-8\text{ mA}$	*	-0.1	-	0.1	V
AVDD Accuracy	Err_{AVDD}	Reg00 = 0x40 ($V_{AVDD} = 10.04\text{ V}$), $I_{AVDD} = 50\text{ mA}$	*	-2.1	-	2.1	%
VCOM Accuracy	Err_{VCOM}	Reg01,02 = 0x100 ($V_{VCOM} = 5.005\text{ V}$), $I_{VCOM} = 10\text{ mA}$	*	-2.1	-	2.1	%
VGH Accuracy	err_{VGH}	Reg04 = 0x40 ($V_{VGH} = 20.65\text{ V}$), $I_{VGH} = 2\text{ mA}$	*	-2.5	-	2.5	%
VGL Accuracy	err_{VGL}	Reg03 = 0x20 ($V_{VGL} = -8.39\text{ V}$), $I_{VGL} = -4\text{ mA}$	*	-2.5	-	2.5	%
VCOM Step Size				10		mV	
VCOM Load Regulation ^[2]	$V_{VCOMreg}$	$I_{LOAD} = 2\text{ to }20\text{ mA}$, $V_{VCOM} = 5.0\text{ V}$	*	-5	-	5	mV
VCOM Temperature Coefficient ^[2]	TC_{VCOM}	$V_{VCOM} = 5\text{ V}$, $-30^\circ\text{C} < T_A < 85^\circ\text{C}$, $I_{LOAD} = 10\text{ mA}$	*	-100	-	150	$\mu\text{V}/^\circ\text{C}$
Minimum Dropout for VCOM from AVDD	$V_{VCOM(DO)}$	$V_{AVDD} = 7\text{ V}$, $I_{VCOM} = 20\text{ mA}$		-	-	1.5	V
FAULT PIN							
FAULT Pull-Down Voltage	$V_{FAULT(PD)}$	Fault condition asserted, pull-up current = 1 mA		-	-	0.4	V
FAULT Pin Leakage Current	$V_{FAULT(LKG)}$	Fault condition cleared, pull-up to 5 V		-	-	1	μA
PROGRAMMABLE DELAYS AND TIMERS							
Startup Timeout/Watchdog Timer (Time limit for all outputs to reach 90% target, starting from internal EN=H)	$t_{SU_TO_min}$	Minimum timeout when Reg0x9 = 0x03 or lower		-	9.6	-	ms
	$t_{SU_TO_max}$	Maximum timeout when Reg0x9 = 0x1F		-	99.2	-	ms
Startup Delay Timer#1-4 (One each for AVDD/VCOM/VGL/VGH)	$t_{SU_DLY_min}$	Minimum delay when Reg_X = 0x00, X = 5..8 ^[3]		-	0	-	ms
	$t_{SU_DLY_max}$	Maximum delay when Reg_X = 0xFF, X = 5..8 ^[3]		-	25.5	-	ms
Shutdown Timeout (starting from internal EN = L)	t_{SD_TO}	All outputs discharged to below 10% target (30% for VGL and VGH)		40	50	65	ms
Shutdown Delay Timer#5-8 (One each for AVDD/VCOM/VGL/VGH)	$t_{SD_DLY_min}$	Minimum delay when Reg_X = 0x00, X = C,D,E,F ^[3]		-	0	-	ms
	$t_{SD_DLY_max}$	Maximum delay when Reg_X = 0xFF, X = C,D,E,F ^[3]		-	25.5	-	ms
Overcurrent Protection (OCP) Timeout	t_{OCP_TO}	Maximum time for any output to stay in OCP fault condition before shutdown.		40	50	60	ms
Fault Retry Counter	$N_{RESTART}$	Maximum number of fault retries. Programmable through Reg0x0A		0	-	15	
Fault Cool-Down Timer	$t_{RESTART_min}$	Cooldown time between fault shutdown and next retry. Reg0x0B = 0x03 or lower		-	9.6	-	ms
	$t_{RESTART_max}$	Cooldown time between fault shutdown and next retry. Reg0x0B = 0x3F		-	201.6	-	ms

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ELECTRICAL CHARACTERISTICS [1] (continued): Valid at $V_{IN} = 5\text{ V}$, $EN = \text{high}$, $f_{SW} = 2\text{ MHz}$, $V_{AVDD} = 10\text{ V}$, $V_{VGH1} = 20\text{ V}$, $V_{VGL} = -8\text{ V}$, $T_J = T_A = 25^\circ\text{C}$, except * indicates specifications guaranteed for $T_J = T_A = -40^\circ\text{C}$ to 125°C , unless otherwise specified

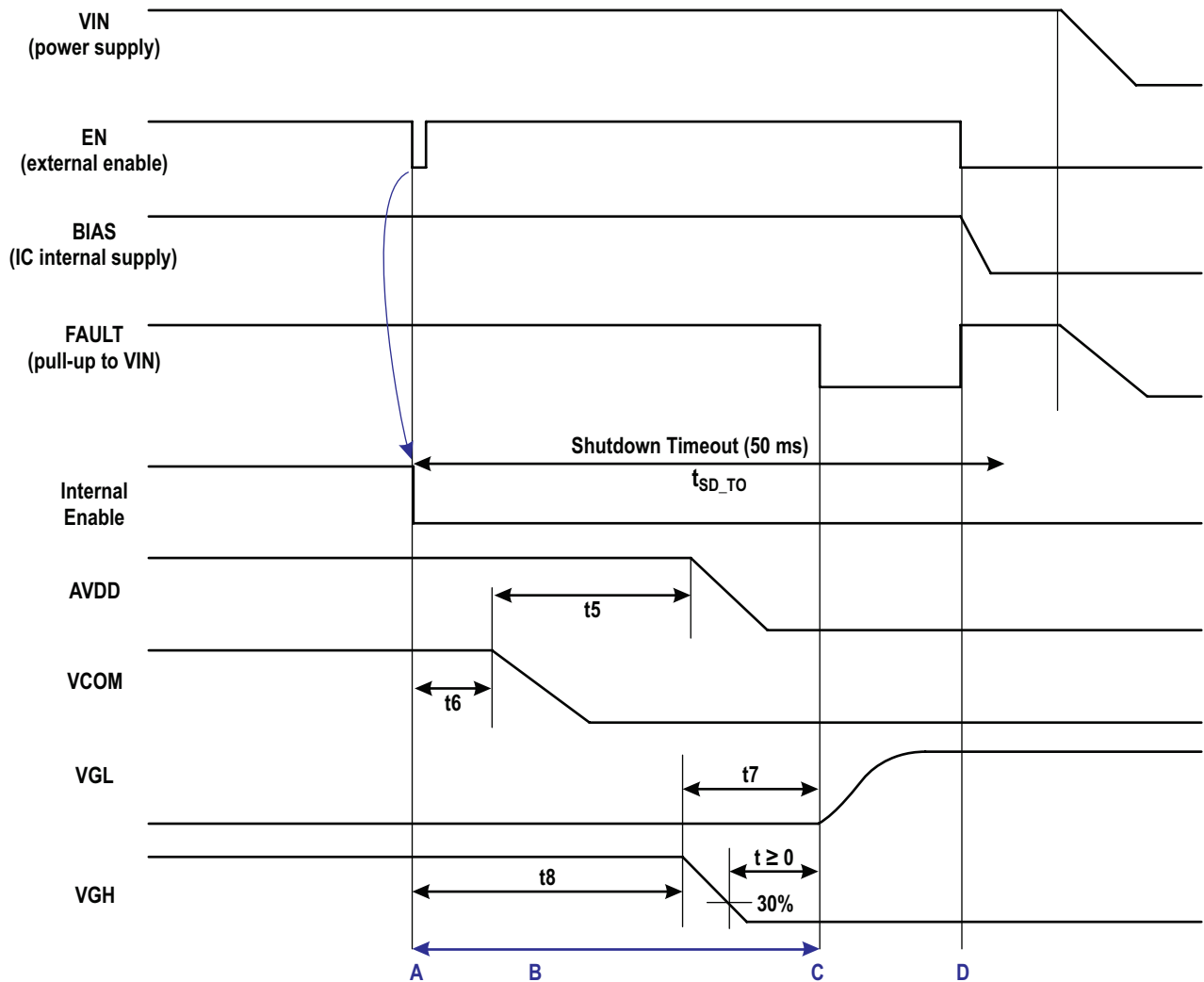
Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
THERMAL SHUTDOWN (TSD) PROTECTION						
TSD Threshold ^[2]	T_{TSD}	Temperature rising	155	165	–	$^\circ\text{C}$
TSD Hysteresis ^[2]	$T_{TSD(HYS)}$		–	20	–	$^\circ\text{C}$
I²C INTERFACE						
Logic Input Low (SDA, SCL)	$V_{SCL(L)}$		–	–	0.8	V
Logic Input High (SDA, SCL)	$V_{SCL(H)}$		2.3	–	–	V
Logic Input Hysteresis ^[2]	$V_{I2CIHYS}$		–	150	–	mV
Logic Input Current	I_{I2CI}		–1	–	1	μA
SDA Output Voltage Low	$V_{I2COu(L)}$	SDA = Low, pull-up current = 2.5 mA	–	–	0.4	V
SDA Output Leakage	I_{I2CLKG}	EN = Low, pull-up to 5.5 V	–	–	1	μA
SCL Clock Frequency	f_{CLK}		–	–	400	KHz
ADDR PIN COMPARATOR THRESHOLD						
Voltage Level for Address 101,0000	$V_{ADDLEVEL1}$	ADDR connected to GND	0	–	0.3	V
Voltage Level for Address 101,0001	$V_{ADDLEVEL2}$		0.6	–	0.9	V
Voltage Level for Address 101,0010	$V_{ADDLEVEL3}$		1.5	–	1.8	V
Voltage Level for Address 101,0011	$V_{ADDLEVEL4}$	ADDR connected to BIAS pin	2.4	–	3	V

¹ For input and output current specifications, negative current is defined as coming out of the node or pin (sourcing), positive current is defined as going into the node or pin (sinking).

² Ensured by design and characterization, not production tested.

³ Refer to Table 5 for Register Map.

Shutdown Timing Diagram



Sequence of events:

- A:** System controller brings EN pin to Low for $>2 \mu s$ to initiate a “Hardware Shutdown.” The IC responds by pulling Internal Enable to Low.
- B:** The A8603 shuts down all output regulators in sequence, according to their shutdown delay times. All registers will be restored to power-up defaults at the end of a Hardware Shutdown. This does not apply to a Software Shutdown when user programs $INT_EN = L$.
- C:** After the last regulator has shut down, the A8603 resets all internal registers to their power-on defaults, sets the $HARD_RESET$ status bit to 1, and pulls FAULT pin to Low. The A8603 is now ready to accept new I²C commands.
- D:** The A8603 is powered down only if $EN = L$ after shutdown has completed.

Notes on Shutdown Timing Diagram

- Each regulator has a programmable Shutdown Delay timer. Each timer has a resolution of 0.1 ms and a maximum duration of 25.5 ms.
- AVDD can only be turned off after VCOM is turned off ($t_5 = 0$ is allowed)
- VGL can only be turned off after VGH drops below 30%, even through $t_7 = 0$ is allowed.
- There is no dependency between $\{t_5, t_6\}$ and $\{t_7, t_8\}$
- Once a shutdown is in progress, both external Enable and Internal EN are ignored until shutdown is completed.
- All output discharge times are based on external capacitance and internal pull-down resistance (250 Ω for AVDD and VCOM, 500 Ω for VGH and VGL). The external DC load is assumed to be negligible.
- If any of the regulator output does not decay to below 10% (30% for VGL and VGH) of target voltage after 50 ms time-out period, starting from beginning of shutdown, it is ignored and then the IC is allowed to power down.

FUNCTIONAL DESCRIPTION

The A8603 is a flexible multivoltage regulator designed for LCD panel bias applications. It utilizes a high-efficiency boost converter, together with space-saving low-dropout (LDO) regulator and charge pump circuits to provide four independently adjustable voltage outputs:

- AVDD: Typically between 5 and 15 V. Nominal output current 100 mA. This output is from a LDO powered by VOUT.
- VCOM: Typically between 3 and 7.5 V at 20 mA. The power supply of this regulator is internally connected to AVDD. Therefore AVDD must be at least 1.5 V higher than the upper limit of VCOM.
- VGL: Typically between -12 and -4 V at 4 mA. This voltage is generated by an inverted charge pump, which is powered by VOUT.
- VGH: Typically between 10 and 24 V at 4 mA. This voltage is generated by a 2× charge pump, which is powered by VOUT.

If necessary, an external 3× charge pump can generate a higher VGH between 20 and 30 V at 4 mA.

Program Diagnostics

A8603 features the I²C (Inter-Integrated Circuit, alternatively spelled as I2C) serial interface and programmable memory array.

The I²C serial interface allows external microcontroller or some type of master device to communicate with A8603 as its slave

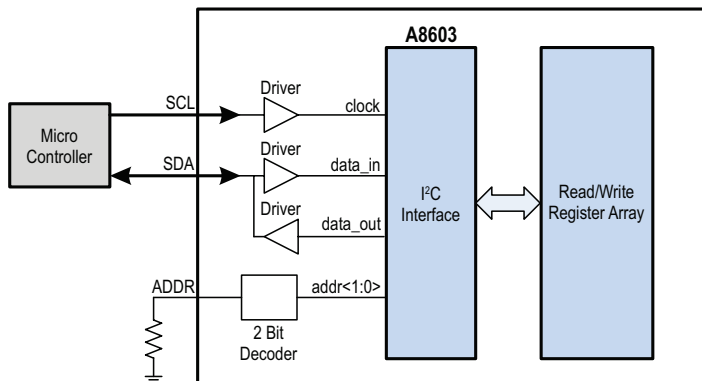


Figure 1: I²C Serial Interface and Programmable Memory Array

device. Two bus lines, SCL and SDA, provide access to the internal control registers. The clock input on the SCL pin is generated by the master, while the SDA line functions as either an input or an open-drain output for the A8603, depending on the direction of the data flow.

In case there are two or more slave devices in an I²C network, each device must present a unique physical address for the master to select. To avoid conflict, the A8603 uses a 4-level ADDR pin to set its physical address. Depending on the voltage level at ADDR, the physical address is set as '101,00xx', where xx = {00 | 01 | 10 | 11}. This is illustrated by the figure below.

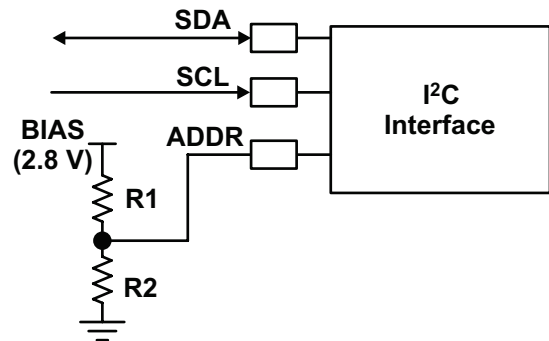


Figure 2: Select I²C Address by Using Resistor Divider at ADDR Pin

Table 1: I²C Address Selection Using Resistor Divider

R1 (k)	R2 (k)	V _{ADDR} (V)	I ² C Address
open	0	0	101,0000
27.4	10	0.75	101,0001
6.98	10	1.65	101,0010
0	open	2.8	101,0011

Programmable Regulators

The A8603 has four voltage regulators: AVDD, VCOM, VGL, and VGH.

Target voltages of all four regulators are programmable by internal registers. In addition, other features (such as startup and shutdown sequences, Fault retry counter, etc.) can also be programmed.

The target voltage for each output regulator is programmed by writing to a register, according to the following equation:

$$\text{Target_Voltage} = \text{Min_voltage} + \#steps \times \text{step_size}$$

For example, to set AVDD to 12 V, the user should write '0x59' to Reg0x00. This is because:

$$\begin{aligned} \#steps &= (\text{Target_Voltage} - \text{Min_Voltage}) / \text{step_size} \\ &= (12 - 5) / 0.07874 = 88.9 \end{aligned}$$

So the content of Reg0x00 is 89 in decimal, or '0x59' in hexadecimal.

Table 2: Target Voltages

Output Regulator	Register	Min. Voltage (V)	Max. Voltage (V)	DAC # of Bits	DAC # of Steps	Step Size (mV)
AVDD	00	5 (Reg=0x00)	15 (0x7F)	7	127	78.74
VCOM	01, 02	2.5 (0x0000)	7.5 (0x01FF)	9	511	9.785
VGL	03	-3.6 (0x00)	-13.03 (0x3F)	6	63	-149.7
VGH	04	9.9 (0x00)	31.236 (0x7F)	7	127	168

*Note: AVDD must be at least 1.5V higher than VCOM, so not all combinations of VCOM and AVDD are possible.

Table 3: Startup Time Delay

Refer to Startup Timing Diagram on how those time delays are defined.

Timer	Min. Delay (ms)	Max. Delay (ms)	Step Size (ms)	Number of Bits
t1 = AVDD	0 (0x00)	25.5 (0xFF)	0.1	8
t2 = VCOM	0	25.5	0.1	8
t3 = VGL	0	25.5	0.1	8
t4 = VGH	0	25.5	0.1	8

Table 4: Shutdown Time Delay

Refer to Shutdown Timing Diagram on how those time delays are defined.

Timer	Min. Delay (ms)	Max. Delay (ms)	Step Size (ms)	Number of Bits
t5 = AVDD	0 (0x00)	25.5 (0xFF)	0.1	8
t6 = VCOM	0	25.5	0.1	8
t7 = VGL	0	25.5	0.1	8
t8 = VGH	0	25.5	0.1	8

Name	Register	Default	Min.	Max.	Step Size	Number of Bits
Watchdog Timer	0x09	51.2 (0x10) ms	9.6 (0x03) ms	99.2 (0x1F) ms	3.2 ms	5
Cooldown Timer	0x0B	102.4 (0x20) ms	9.6 (0x03) ms	201.6 (0x3F) ms	3.2 ms	6
Fault Retry Counter	0x0A	8 (0x08)	0 (0x00)	15 (0x0F)	1	4

Dithering:

Reg0x10 bit[0,1]: controls Dithering off, ±5%, 10% or 15%.

Power Sequence:

Reg0x10 bit4: By default VGL is enabled before VGH during power-up. But if this bit is set to '1', then VGH is enabled first.

Table 5: I²C Register Map

Registers	Default	Address	Comments
Regulator Programming			
		0x00-0x13	
AVDD_voltage	0x40	0x00	7 bits adjust AVDD regulator output from 5 V to 15 V in 78.74 mV step.
VCOM_voltage_msb	0x1	0x01	9 bits adjust VCOM regulator output from 2.5 V to 7.5 V in 9.785 mV step. Must be programmed in the order of MSB followed by LSB.
VCOM_voltage_lsb	0x0	0x02	
VGL_voltage	0x20	0x03	6 bits adjust VGL regulator output from -3.6 V to -13.03 V in -150 mV step.
VGH_voltage	0x40	0x04	7 bits adjust VGH regulator output from 9.9 V to 31.236 V in 168 mV step.
delay_startup_AVDD	0x0	0x05	Program the turn-on delay for AVDD. 100 µs step size. 0 ms to 25.5 ms.
delay_startup_VCOM	0x20	0x06	Program the turn-on delay for VCOM (after AVDD). 100 µs step size. 0 ms to 25.5 ms. See Startup Timing diagram.
delay_startup_VGL	0x40	0x07	Program the turn-on delay for VGL. 100 µs step size. 0 ms to 25.5 ms.
delay_startup_VGH	0x40	0x08	Program the turn-on delay for VGH (after VGL). 100 µs step size. 0 ms to 25.5 ms.
watchdog_timer	0x10	0x09	Maximum time allowing regulator to reach its target value. 3.2 ms step. 9.6 ms to 99.2 ms. Same value is used for all regulators.
fault_counter	0x8	0x0A	Programmable counter allowing system to reattempt 0 to 15 times at the event of fault.
cooldown_timer	0x20	0x0B	Prevent immediate reattempt after the fault. System will wait for timer to expire before possible reattempt to turn on the regulators. Step size 3.2 ms. Range 9.6 ms to 201.6 ms.
delay_shutdown_AVDD	0x0	0x0C	Program the turn-off delay for AVDD (after VCOM). 100 µs step size. 0 ms to 25.5 ms. See Shutdown Timing diagram.
delay_shutdown_VCOM	0x0	0x0D	Program the turn-off delay for VCOM. 100 µs step size. 0 ms to 25.5 ms.
delay_shutdown_VGL	0x0	0x0E	Program the turn-off delay for VGL (after VGH). 100 µs step size. 0 ms to 25.5 ms.
delay_shutdown_VGH	0x0	0x0F	Program the turn-off delay for VGH. 100 µs step size. 0 ms to 25.5 ms.
dither	0x0	0x10	Bit[1,0] for dither programming (off/5%/10%/15%); Bit4 for VGL/VGH power sequence option.
regulator_internal_enable	0x0	0x11	'1' = Turn all regulators on. '0' = OFF
spare1	0x0	0x12	Spare
spare2	0x0	0x13	Spare
Fault Status			
		0x14-0x1B	
output_status_now	0x0	0x14	Present output voltage status of regulators (over 10%, 30%, or 90%)
ilimt_status_now	0x0	0x15	Present output current status of regulators (OCP)
fault_status_now	0x0	0x16	Present fault status (TSD, FSET_short, SW_OVP, SW_OCP, etc.)
output_status_hold	0x0	0x17	Latched output voltage status (over 120% or under 80%)
ilimt_status_hold	0x0	0x18	Latched output current status
fault_status_hold	0x0	0x19	Latched fault status
rstatus_hold	0x01	0x1A	Retry counter status [bit 4:7], Diagnostic [2,3], Hard_Reset [1], and POR [0].
sstatus_hold	0x0	0x1B	OVP/UVP status of regulators during startup

DIAGNOSTIC REGISTERS

All faults and critical signals are recorded into log registers. External devices can read these log registers for diagnostic or maintenance purposes.

The A8603 provides two types of diagnostic status registers:

- Registers 0x14-16 (#20-22 in decimal) store the real-time status bits for regulator voltage, current, and fault conditions.
- Registers 0x17-1B (#23-27 in decimal) store the ‘latched’ status bits for voltage, current, and fault conditions. In case of a fault shutdown, the real-time status bits may be cleared, but the user can read the latched status bits and determine the cause for the shutdown.

Real-Time Status Registers

Registers 0x14 to 0x16 are read-only (refer to Tables 6 - 8).

Table 6: Register 0x14 – Output Voltage Status During Startup/Shutdown

bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
VGH > 90%	VGL > 90%	VCOM > 90%	AVDD > 90%	VGH > 30%	VGL > 30%	VCOM > 10%	AVDD > 10%

Each bit is set to ‘1’ when its corresponding regulator voltage is above threshold. They are only useful during startup and shutdown.

Table 7: Register 0x15 – Output Current Status During Operation

bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
-	-	-	-	VGH ILimit	VGL ILimit	VCOM ILimit	AVDD ILimit

Each bit is set to ‘1’ when its corresponding regulator is operating at current limit. Note that those bits are ignored during startup phase (where all regulators must work at current limit to charge up output capacitors quickly). During normal operation mode, it is acceptable for any regulator to reach its current limit momentarily. Only if the overcurrent condition persists for 50 ms, then the FAULT pin is pulled down and a RailFault (Reg0x16 bit2) is recorded.

Table 8: Register 0x16 – Fault Status

bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
FAULT	MaxRetry	WatchDog	SW ILimit2	SW OVP	Rail Fault	FSET fault	TSD

Explanation of each bit:

Bit7 = 1 if any Fault has occurred (it is *not* set in case of a POR or Hard-Reset).

Bit6 = 1 if the number of fault retries has reached MaxRetry limit.

Bit5 = 1 if the startup watchdog timer (Reg0x09) has expired before all output regulators can reach 90% target.

Bit4 = 1 if the boost switch current has exceeded its secondary OCP limit (150% of cycle-by-cycle current limit).

Bit3 = 1 if the boost switch voltage has exceeded its OVP threshold.

Bit2 = 1 if any output regulator reached its OCP limit for 50 ms.

Bit1 = 1 if the FSET pin is either open or shorted to GND.

Bit0 = 1 if a thermal shutdown has occurred.

Latched Status Registers

Registers 0x17 to 0x1B hold the status bits after a fault has occurred. Each bit is read-only and can be only cleared by writing a '1' to it. In case of a fault shutdown, the user can read those registers to determine the cause of the shutdown, and then clear them by writing '0xFF' to each register.

Table 9: Register 0x17 – Latched Output Over- and Undervoltage Protection Fault

bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
VGH > 120%	VGL > 120%	VCOM > 120%	AVDD > 120%	VGH < 80%	VGL < 80%	VCOM < 80%	AVDD < 80%

Each bit is set to '1' when its corresponding regulator has tripped OVP/UVP fault. Note that those bits can only be set after all regulators have finished startup stage and the IC is in normal operation mode.

Table 10: Register 0x18 – Latched Output Overcurrent Protection Fault

bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
Reserved	-	-	-	VGH ILimit	VGL ILimit	VCOM ILimit	AVDD ILimit

Each bit is set to '1' when its corresponding regulator is operating at current limit during normal operation.

Table 11: Register 0x19 – Latched Fault Status

bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
FAULT	MaxRetry	Watchdog	SW ILimit2	SW OVP	Rail Fault	FSET fault	TSD

See Register 0x16 for explanation of each bit.

Table 12: Register 0x1A – Latched Non-Fault Status

bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
Current Retry Counter (Read-Only)				SW ILimit1	Slow Shutdown	Hard Reset	Power-On Reset

Bit[4..7] = Current Retry Counter (0 to 15)

Bit3 = 1 if boost switch cycle-by-cycle current limit has been reached. This is not a fault condition and IC does not shutdown.

Bit2 = 1 if during shutdown, any regulator failed to decay below 10% (AVDD/VCOM) or 30% (VGL/VGH) before watchdog timer expires. This is not a fault since the IC still shuts down afterward.

Bit1 = 1 if the IC has finished a hardware-initiated shutdown (by EN = L briefly) and all registers are restored to default values.

Bit0 = 1 if the IC has finished a power-on reset and all registers are initialized to their default values.

Note that after a Power-On Reset (or a Hard Reset), the output regulator cannot be enabled until bit0 (or bit1) is cleared. This can be done by writing a '0x03' to Register0x1A.

Table 13: Register 0x1B – Latched Over- and Undervoltage Status During Startup

bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
VGH > 120%	VGL > 120%	VCOM > 120%	AVDD > 120%	VGH < 80%	VGL < 80%	VCOM < 80%	AVDD < 80%

This is similar to Register 0x17, except it only records OVP/UVP during startup phase. Suppose, under certain unlikely situations, a regulator output rises above 120% or drops below 80% after it reached 90% but before the IC enters normal operation mode, then it will be recorded.

DESCRIPTION OF REGULATORS

AVDD Regulator

The AVDD output is driven by a linear regulator, which takes its input power from the boost output voltage. The target voltage of AVDD is programmable through Register 0x00 (7 bits). Its range is between 5 V (Register = 0x00) and 15 V (Register = 0x7F) in 127 steps, with step resolution = 78.74 mV. A representative block diagram is shown in Figure 3.

The AVDD circuit monitors the voltage drop across its linear regulator. If this voltage drop is less than the headroom required (approximately 2 V between OUT and AVDD), the monitor circuit sends a control signal to cause the boost voltage to increase. This ensures there is always enough headroom for regulation.

VCOM Regulator

The VCOM output is also driven by a linear regulator similar to the case of AVDD, except that it takes its input power from the regulated AVDD output voltage. This arrangement gives VCOM exceptional stability over full operating temperature range. The target voltage of VCOM is programmable through Register 0x01-02 (9 bits total). Its range is between 2.5 V (Register=0x0000) and 7.5 V (Register=0x01FF) in 511 steps, with step resolution = 9.785 mV.

In order to ensure there is enough headroom, AVDD must be at least 1.5 V higher than VCOM.

If VCOM is not required, the VCOM pin can be left open, but a small output capacitor (approximately 0.1 μ F) must be present to prevent oscillation.

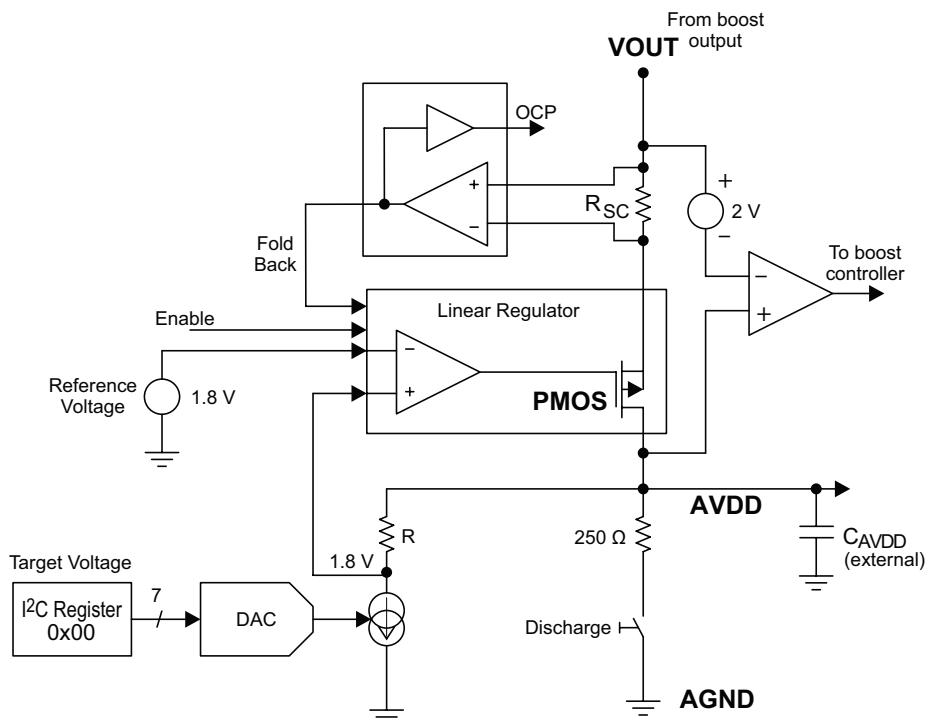


Figure 3: Representative Block Diagram of the AVDD Regulator

VGL/VGH Charge Pumps

The A8603 uses a 2× charge pump to generate VGH from boost voltage. If necessary, a 3× charge pump can be implemented at the VGH3 pin using external components. See Representative Block Diagrams as shown in Figures 4 and 5. Depending on the

magnitude of VGH, using a 3× charge pump may lower the boost output voltage and hence improve the system efficiency. See Boost Controller section for details.

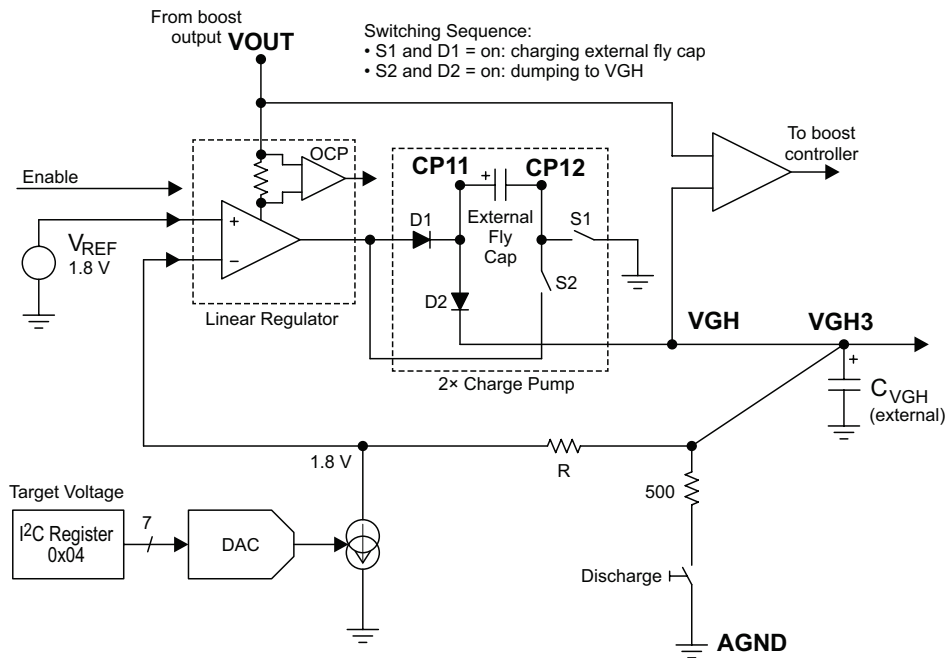


Figure 4: Representative Block Diagram of the VGH Regulator in 2× Charge Pump Mode

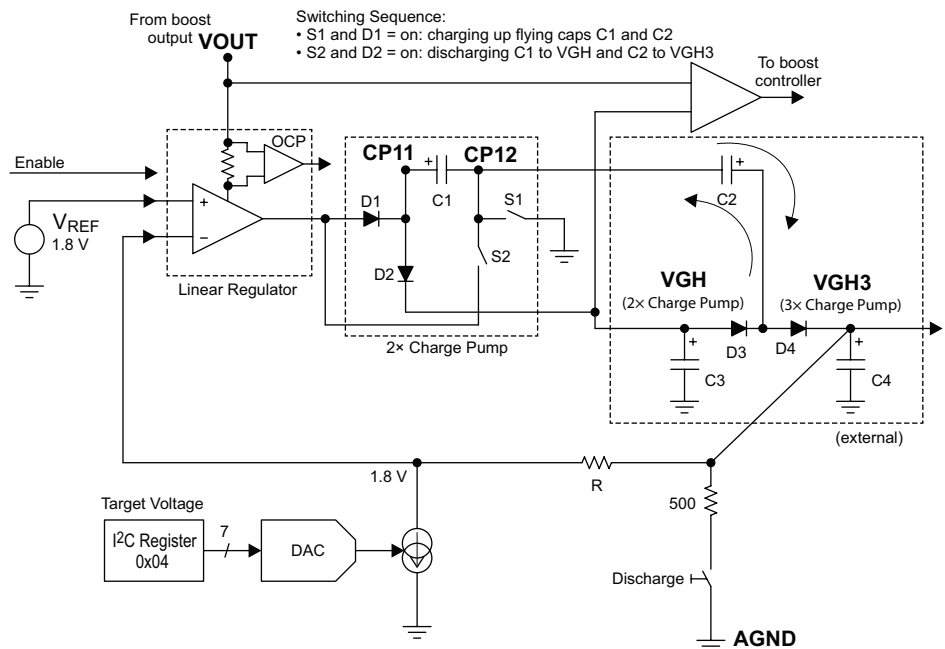


Figure 5: Representative Block Diagram of the VGH Regulator in 3× Charge Pump Mode

An inverting charge pump is used to generate the negative voltage for VGL. A representative block diagram is shown in Figure 6.

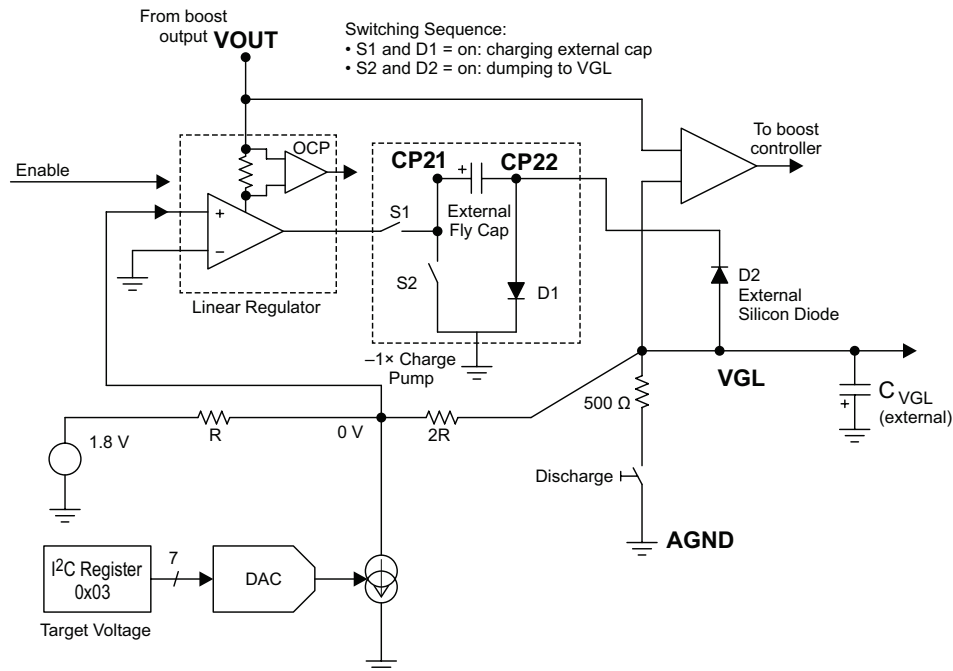


Figure 6: Representative Block Diagram of the VGL Negative Charge Pump Mode

The frequency of the charge pumps is the same as the boost switching frequency (or external SYNC frequency). When an external SYNC signal is used, it is internally converted into a clock signal with the same frequency, but at 50% duty cycle.

Recommended values of the external flying capacitor, C_{FLYx} , on the C_{Pxx} pins depends on the switching frequency as shown in the following table; a voltage rating of 25 V is sufficient.

Table 14: Recommended Flying Capacitor Values

Switching Frequency (MHz)	C_{FLYx} (μ F)
2	0.1
1	0.22
0.35	0.47

The value of the flying capacitor can be calculated as follows:

1. The equivalent series resistance of the flying capacitor is:

$$ESR_{FLY2} = 1 / (f_{SW} \times C_{FLY2}) \quad (2)$$

2. Assuming a flying capacitor ripple voltage of 100 mV, and a maximum output current of 20 mA, the series resistance is:

$$R_{FLY2} \leq 0.1 (V) / 0.02 (A) = 5 \Omega$$

3. Therefore at an f_{SW} of 2 MHz, the required capacitance, C_{FLY2} , is 0.1 μ F.

Boost Controller

The A8603 contains an integrated DMOS switch and PWM controller to drive a boost converter. The input voltage, V_{IN} , (3.3 V nominal) is boosted to an intermediate voltage, V_{OUT} , which is the lowest voltage required to keep all outputs within regula-

tion. The final output voltage is decided by the regulator, which requires the highest boost voltage. This is illustrated in Figure 7.

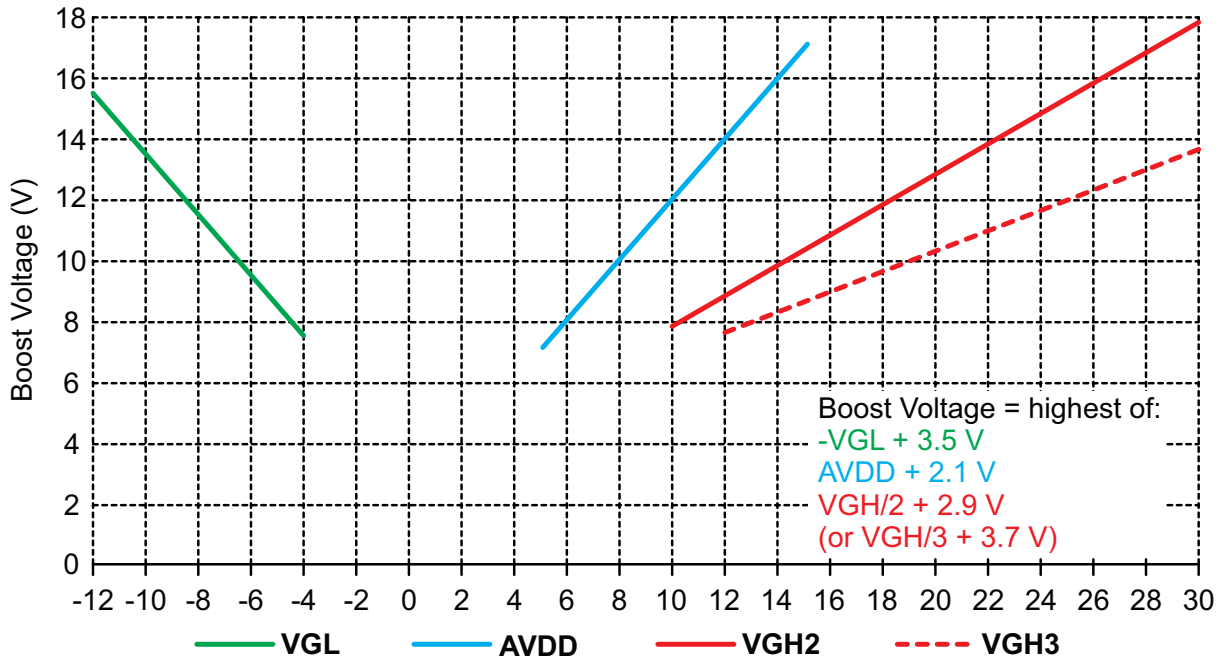


Figure 7: Boost Voltage Requirement with Respect to VGL, AVDD and VGH

For example: assume the output requirements for a certain LCD panel are: $V_{AVDD} = 10$ V, $V_{VGH} = 18$ V and $V_{VGL} = -7$ V, then:

- AVDD (LDO):

$$V_{OUT} \geq V_{AVDD} + 2.1 (V) = 12.1 V$$

- VGH (2× Charge Pump):

$$V_{OUT} \geq V_{VGH} / 2 + 2.9 (V) = 11.9 V$$

- VGL (Inverted Charge Pump):

$$V_{OUT} \geq -V_{VGL} + 3.5 (V) = 10.5 V$$

In this example, AVDD has the highest requirement, so the boost output voltage will be regulated at a $V_{OUT} = 12.1$ V approximately. However, if V_{VGH} were increased to 24 V, it would require higher voltage, and then the boost converter would increase the boost output voltage to 14.9 V to satisfy the 2× charge pump. This leads to higher voltage drop across the linear regulator for AVDD, and hence higher power loss. In such case, it

is worthwhile to consider the option of 3× charge pump for VGH.

- VGH (2× Charge Pump):

$$V_{OUT} \geq V_{VGH} / 2 + 2.9 (V) = 14.9 V$$

- VGH (3× Charge Pump):

$$V_{OUT} \geq V_{VGH} / 3 + 3.7 (V) = 11.7 V$$

So by using 3× charge pump for VGH, the boost voltage is reduced to 12.1 V (as dominated by AVDD). This results in lower power loss and hence better system efficiency.

A block diagram of the A8603 boost controller circuit is shown in Figure 8. Typical values for external COMP components are $R_Z = 511 \Omega$ and $C_Z = 0.22 \mu F$. Note that the boost stage simply provides an intermediate voltage. The actual output voltages (AVDD, VGL, VGH) are controlled by linear regulators and charge pumps, which contain their own internal compensation.

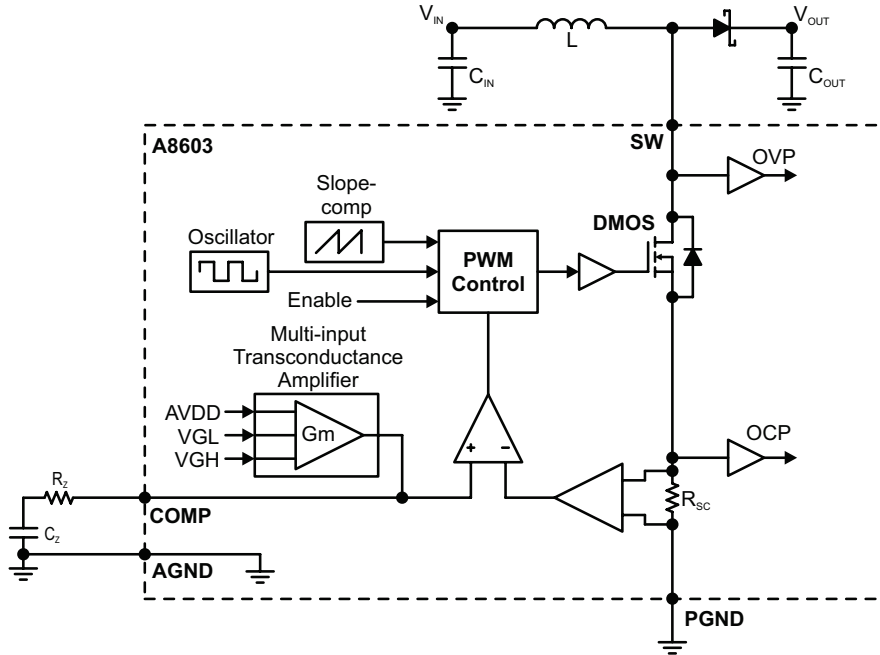


Figure 8: Boost Controller Circuit

The boost controller is protected against overvoltage and overcurrent fault conditions.

- The Switch OVP threshold, $V_{SW(OVP)}$, is internally set at approximately 21 V typical. Under normal operating conditions, the boost output voltage should always be lower than 18 V, so only in the event of a fault will SW_OVP be tripped (for example: boost diode open or VOUT pin open during startup).
- The switch current is protected by a cycle-by-cycle current limit (I_{SWLIM} , 2.6 A typical). In the event of a heavy load or during a transient, the SW peak current may reach

SWILIM level momentarily. In this case, the present on-time is truncated immediately, but no signal is generated on the FAULT pin. The switching will continue with the same period.

- In the event of a catastrophic failure (such as shorted inductor), the SW current may exceed SWILIM2, which is 150% of the SWILIM threshold. In this case, the IC is shut down immediately.

It is important to note that the A8603 cannot protect the input current in case there is a short from boost output to GND. To do so requires the use of an input disconnect switch.

Boost Switching Frequency

The boost stage switching frequency, f_{SW} , of the A8603 can be programmed by using an external resistor between the FSET pin to GND, or it can be synchronized to an external clock frequency between 350 kHz and 2.25 MHz.

During startup, the A8603 senses the FSET pin for any external SYNC signal. If periodic logic transitions are detected (Low < 0.4 V or High > 1.5 V), this is evaluated as an external clock signal, and the boost switching frequency is synchronized to it. If no periodic signal is detected, the bias current flowing through FSET_SYNC pin is used to determine the switching frequency. The bias current is set by an external resistor, R_{FSET} , on the FSET_SYNC pin. The relation between R_{FSET} and switching frequency is given as:

$$R_{FSET} = 10.21 / (f_{SW} - 0.0025) \quad (3)$$

where R_{FSET} is in k Ω and f_{SW} is in MHz.

This relationship is charted in Figure 9. For example, to get a switching frequency of 2 MHz requires an R_{FSET} of 5.11 k Ω .

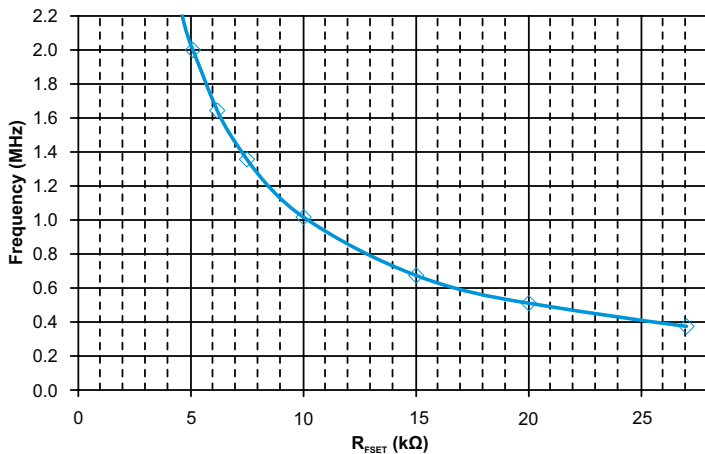


Figure 9: Boost Switching Frequency as a Function of FSET Resistance

Suppose the A8603 is started up with a valid external SYNC signal, but the SYNC signal is lost during normal operation. In that case, one of the following happens

- If the external SYNC signal is high impedance (open), the A8603 continues normal operation, at the switching frequency set by R_{FSET} . No FAULT flag is generated
- If the external SYNC signal is stuck at low (shorted to ground), the A8603 begins a shutdown sequence, at the switching frequency set by the internal 1 MHz oscillator. The FAULT pin is pulled low and the internal error counter is increased by 1.

Note:

To prevent generating a fault when the external SYNC signal is stuck at low, the circuit shown in Figure 10 can be used. When the external SYNC signal goes low, the A8603 will continue to operate normally at the switching frequency set by R_{FSET} . No FAULT flag is generated.

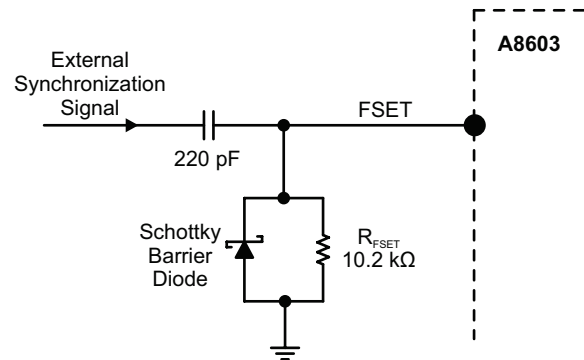


Figure 10: Countermeasure to Prevent External Sync Signal Stuck-at-Low Fault

Boost Frequency Dithering

The A8603 has an optional dithering function for the boost switching frequency. When enabled, the switching frequency is varied linearly within a certain frequency range, as modulated by a triangular ramp signal. By spreading the frequency of the boost converter, the overall system noise magnitude can be greatly reduced. Note that the frequency dithering function is not available when an external synchronization signal is used at the FSET pin.

The dithering feature is controlled by Register 0x10. Frequency of the dithering modulation ramp signal is 12 kHz typical.

Table 15: Register 0x10 Dithering Feature

Reg0x10 Content (in binary)	Dithering Feature (frequency range)
'00'	0%
'01'	±5%
'10'	±10%
'11'	±15%

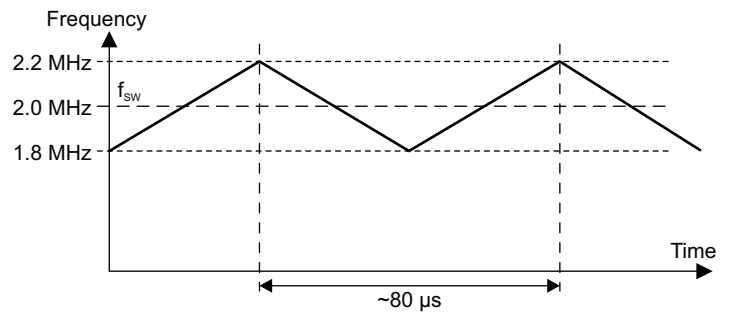


Figure 11: Switching Frequency Varied Linearly
 In this example, Reg0x10 = '10' and the central switching frequency is $f_{SW} = 2.0$ MHz. The actual frequency is varied linearly between $f_{SW} - 10\%$ and $f_{SW} + 10\%$ by the modulating frequency at 12 kHz.

FAULT CONDITIONS

The A8603 has extensive fault detection mechanisms, to protect against all perceivable faults at the IC level (pin open, pin short to GND, pin short to neighboring pins, and so forth) and at the system level (external component open/short, component value changes from -50% to $+100\%$, and so forth).

The FAULT pin of the A8603 has an open-drain pull-down device internally. An external resistor is required to pull this pin to the desired logic-high level (such as 5 V or 3.3 V) at no-fault. Choose a resistor value such that, in case of fault, the current into the FAULT pin is not more than 1 mA. For example, if the external supply is 5 V, then the pull-up resistor should be 5 k Ω or higher.

In general, if a fault is detected, the A8603 halts operation and pulls the FAULT pin low. It then attempts to restart operation after a delay, t_{RESTART} (programmable between 10 and 200 ms). Internally there is a Fault counter that keeps track of how many times any fault has occurred. If the Fault counter reaches maximum retry limit (programmable between 0 and 15), the A8603 stops any further attempts and returns to initial state with all regulators disabled. The Fault status register can be read through I²C commands, but internal enable signal is prohibited in this state. The Fault counter is cleared only by a completed shutdown sequence after EN = low, or by a power reset (V_{IN} drops below UVLO).

As an example: If the FSET pin is either open or shorted to GND, the A8603 will report a fault by asserting FAULT = L once EN = H. All output regulators are disabled in this case, but the user can still use an I²C Read command to read the fault status registers, and find out which type of fault has occurred. See “Diagnostic Registers” section for details.

Over- and Undervoltage Protections

All regulator output pins (AVDD, VGL, VGH, VCOM) are monitored for overvoltage and undervoltage faults during normal operation.

In case of an output short, the output voltage may make a sudden change that is either $+20\%$ over, or -20% under the target voltage. This will trigger the OVP/UVF fault and force the A8603 to shut down. The offending regulator is turned off immediately. The other outputs are then shut down following normal sequence.

OVP/UVF detections are disabled during the startup sequence. If any output fails to reach 90% of its target voltage within a time-out period, $t_{\text{SS(To)}}$ (50 ms typical), a fault is generated and then the A8603 shuts down.

Each regulator output (AVDD, VGH, VGL and VCOM) is protected by its own independent overcurrent limit. When an output current exceeds its limit, the corresponding regulator goes into overcurrent protection mode to protect itself from damage. See next section for illustrations of the protection characteristics.

If the overcurrent condition persists for 50 ms, all regulators are turned off following the normal shutdown sequence. This is different from output OVP/UVF fault, where the offending regulator is shut down immediately, while other regulators are shut down in sequence.

Overcurrent Protection Mechanisms for AVDD, VCOM, VGH and VGL

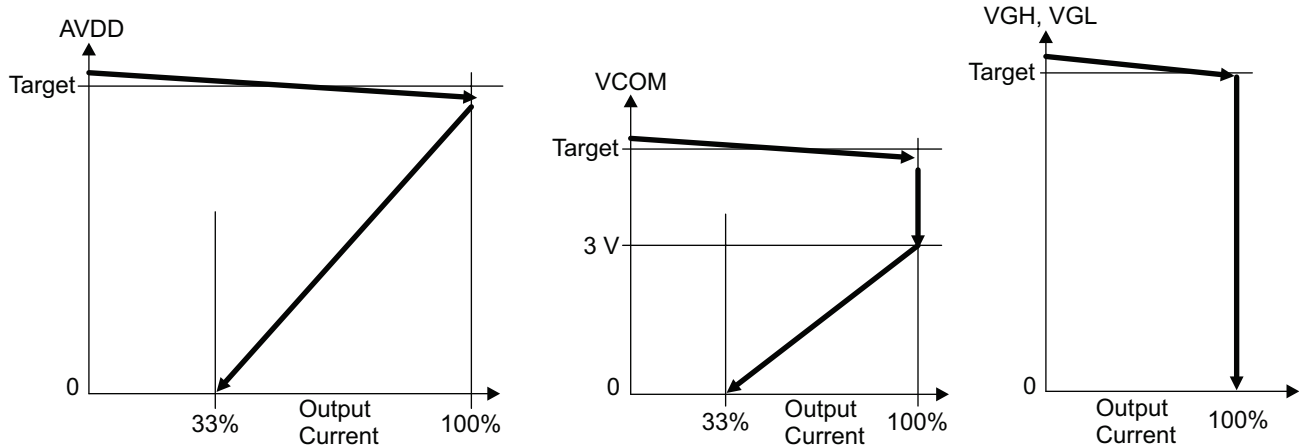


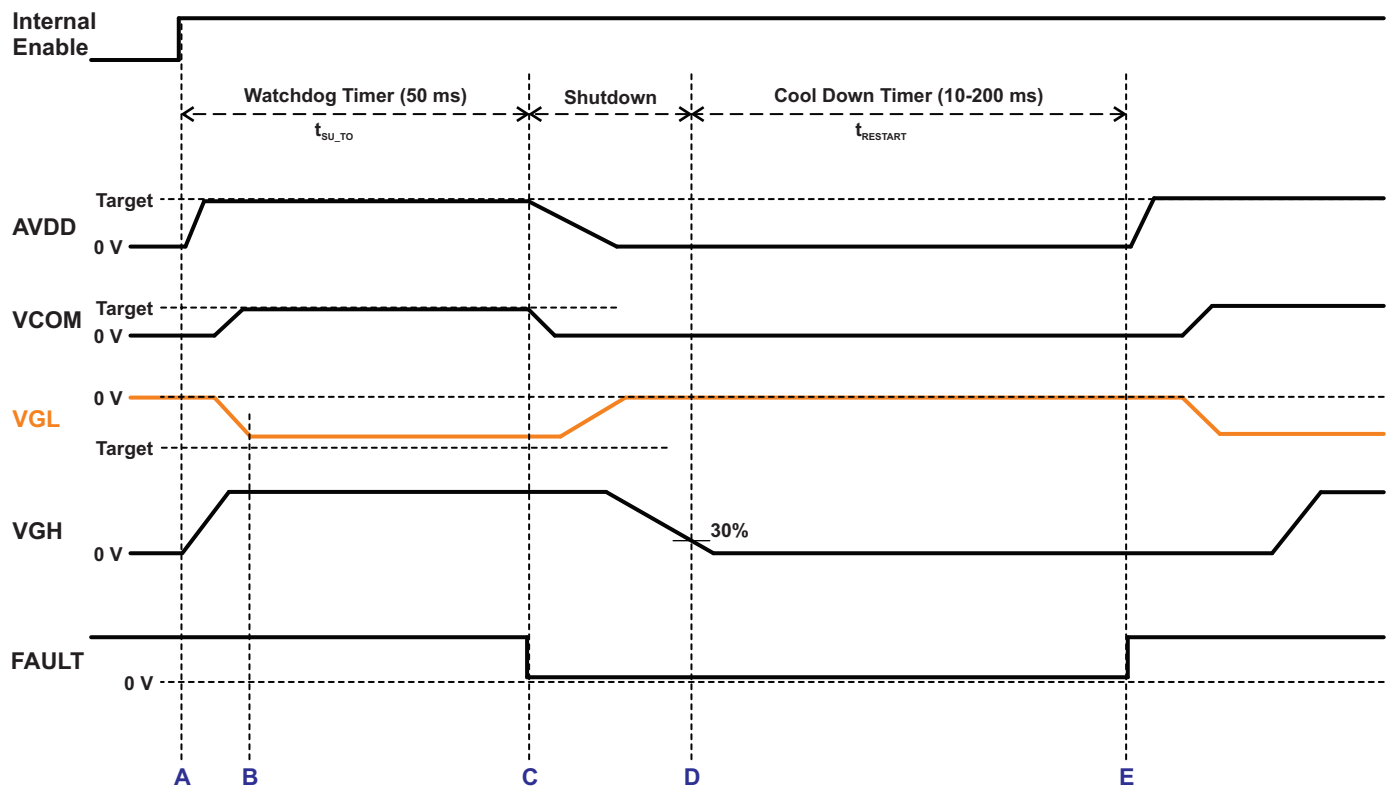
Figure 12: Regulator Current Fold-Back in Case of Overcurrent Conditions

Overcurrent Protection

Each output regulator has a built-in current limit to prevent damages from overcurrent. During startup, a regulator may initially operate in overcurrent protection mode while its output capacitor is being charged. Normally, the current will reduce once the

output voltage has reached target value. In case there is an output short, or if the output capacitor is much larger than expected, the OCP mode may last for 50 ms. At this point, an OCP fault is generated. The IC then begins to shut down all regulators according to programmed shutdown sequence.

Examples of Various Fault Conditions



Sequence of events:

- A: User issues I²C command to set INT_EN = H, to enable all output regulators.
- B: During startup, VGL is unable to reach its regulation target due to an output short or unexpected heavy load.
- C: After Watchdog Timer expired, the A8603 reports that a fault has occurred (by asserting FAULT = L) and begins to shutdown all its output regulators in normal sequence. Fault counter is incremented by 1.
- D: When the last regulator (VGH in this case) has finished shutdown, the A8603 waits for a cooldown period (programmable between 10 and 200 ms).
- E: Retry startup as long as the maximum number of retries (programmable between 0 and 15) is not exceeded.

Figure 13: Timing Diagram where VGL Failed to Reach Its Target Voltage at Startup